

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10544126	ARITSUKA, TOMOHIKO
	<b>Examiner</b>	<b>Art Unit</b>
	Kaplan, Hal I	2836

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
307	17	1/13/2008	HK
307	82	1/13/2008	HK
307	83	1/13/2008	HK
361	35	1/13/2008	HK
361	36	1/13/2008	HK
361	38	1/13/2008	HK
361	67	1/13/2008	HK
323	271	1/13/2008	HK
323	272	1/13/2008	HK
323	275	1/13/2008	HK
323	276	1/13/2008	HK
363	25	1/13/2008	HK
363	39	1/13/2008	HK

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
361/67 (consulted Stephen W. Jackson)	3/29/2007	HK
323/222,271-276; 363/25,37,39,41 (consulted Rajnikant Patel)	3/28/2007	HK
EAST (US- PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	1/13/2008	HK

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
Interference Search History Printout		1/13/2008	HK